LOW-POWER DIFFERENTIAL LINE DRIVER AND RECEIVER PAIRS

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- Designed for High-Speed Multipoint Data Transmission Over Long Cables
- Operate With Pulse Durations as Low as 30 ns
- Low Supply Current . . . 5 mA Max
- Meet or Exceed the Requirements of ANSI Standard RS-485 and ISO 8482:1987(E)
- 3-State Outputs for Party-Line Buses
- Common-Mode Voltage Range of –7 V to 12 V
- Thermal Shutdown Protection Prevents
 Driver Damage From Bus Contention
- Positive and Negative Output Current Limiting
- Pin Compatible With the SN75ALS180

description

The SN65LBC180 and SN75LBC180 differential driver and receiver pairs are monolithic integrated circuits designed for bidirectional data communication over long cables that take on the characteristics of transmission lines. They are balanced, or differential, voltage mode devices that meet or exceed the requirements of industry standards ANSI RS-485 and ISO 8482:1987(E). Both devices are designed using Tl's proprietary LinBiCMOS™ with the low power consumption of CMOS and the precision and robustness of bipolar transistors in the same circuit.

Both the SN65LBC180 and SN75LBC180 combine a differential line driver and receiver with 3-state outputs and operate from a single 5-V supply. The driver and receiver have active-high and active-low enables, respectively, which can be externally connected to function as a direction control. The driver differential outputs and the receiver differential inputs are connected to separate terminals for full-duplex operation and are designed to present minimum loading to the bus whether disabled or powered off (V_{CC} = 0). These parts feature a wide common-mode voltage range making them suitable for point-to-point or multipoint data-bus applications.

D OR N PACKAGE (TOP VIEW)



NC-No internal connection

Function Tables

DRIVER

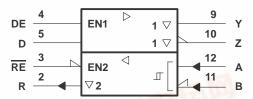
| INPUT | ENABLE | OUTPUTS |
|-------|-----------|---------|
| D | DE | Y Z |
| Н | H WILLIAM | H L |
| L | Н | L H |
| X | L | Z Z |

RECEIVER

| DIFFERENTIAL INPUTS A-B | ENABLE RE | OUTPUT R |
|---------------------------------------------------------|--------------|--------------------|
| V _{ID} ≥ 0.2 V | L | Н |
| $-0.2 \text{ V} < \text{V}_{\text{ID}} < 0.2 \text{ V}$ | L | ? |
| $V_{1D} \le -0.2 \text{ V}$ | L | TOO L |
| X | H | Z |
| Open circuit | - 1 | GO TH H |

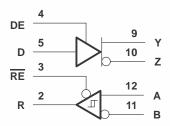
H = high level, L = low level, ? = indeterminate, X = irrelevant, Z = high impedance (off)

logic symbol†



[†]This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)



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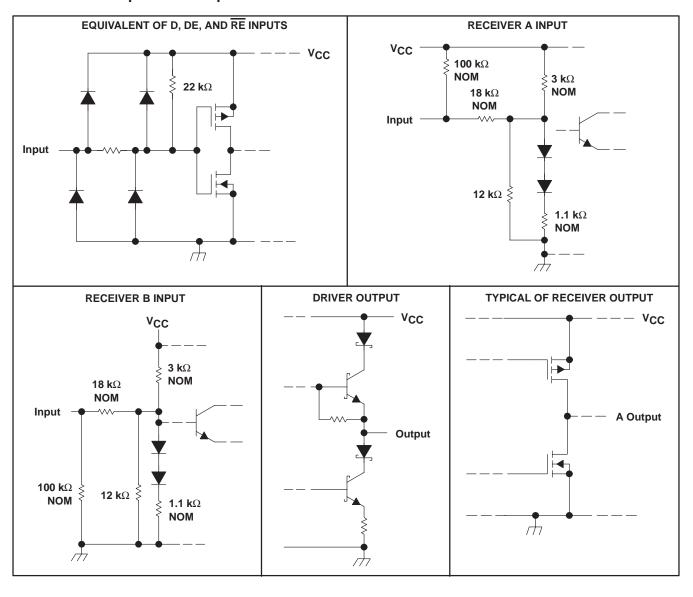
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description (continued)

The devices also provide positive and negative output-current limiting and thermal shutdown for protection from line fault conditions. The line driver shuts down at a junction temperature of approximately 172°C.

The SN65LBC180 and SN75LBC180 are available in the 14-pin dual-in-line and small-outline packages. The SN75LBC180 is characterized for operation over the commercial temperature range of 0° C to 70° C. The SN65LBC180 is characterized over the industrial temperature range of -40° C to 85° C.

schematics of inputs and outputs





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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

| Supply voltage range, V _{CC} (see Note 1) | 0.3 V to 7 V |
|-------------------------------------------------------------------|--------------------------------------------|
| Input voltage range, V _I (A, B)(see Note 1) | |
| Voltage range at D, R, DE, RE (see Note 1) | $-0.3 \text{ V to V}_{CC} + 0.5 \text{ V}$ |
| Continuous total power dissipation (see Note 2) | Internally limited |
| Total power dissipation | See Dissipation Rating Table |
| Operating free-air temperature range, T _A : SN65LBC180 | –40°C to 85°C |
| SN75LBC180 | 0°C to 70°C |
| Storage temperature range, T _{stq} | 65°C to 150°C |
| Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds | 260°C |

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. All voltage values are with respect to GND.

2. The maximum operating junction temperature is internally limited. Use the dissipation rating table to operate below this temperature.

DISSIPATION RATING TABLE

| PACKAGE | $T_{\mbox{\scriptsize A}} \leq 25^{\circ}\mbox{\scriptsize C}$ POWER RATING | DERATING FACTOR ABOVE T _A = 25°C | T _A = 70°C POWER RATING | T _A = 85°C POWER RATING |
|---------|-----------------------------------------------------------------------------|------------------------------------------------|---------------------------------------|---------------------------------------|
| D | 950 mW | 7.6 mW/°C | 608 mW | 494 mW |
| N | 1150 mW | 9.2 mW/°C | 736 mW | 598 mW |

recommended operating conditions

| | | MIN | NOM | MAX | UNIT |
|-------------------------------------------------------------------------|---------------|-----|-----|------|------|
| Supply voltage, V _{CC} | | | | 5.25 | V |
| High-level input voltage, VIH | D, DE, and RE | 2 | | | V |
| Low-level input voltage, V _{IL} | D, DE, and RE | | | 0.8 | V |
| Differential input voltage, V _{ID} | | -6‡ | | 6 | V |
| Voltage at any bus terminal (separately or common mode), VO, VI, or VIC | A, B, Y, or Z | -7‡ | | 12 | V |
| High level output output leve | Y or Z | | | -60 | mA |
| High-level output current, IOH | R | | | -8 | IIIA |
| Lavy laval authorit authorit lav | Y or Z | | | 60 | A |
| Low-level output current, IOL | R | | | 8 | mA |
| Operating free oir temperature T. | SN65LBC180 | -40 | | 85 | °C |
| Operating free-air temperature, Тд | SN75LBC180 | 0 | | 70 | C |

[‡] The algebraic convention where the least positive (more negative) limit is designated minimum, is used in this data sheet for the differential input voltage, voltage at any bus terminal, operating temperature, input threshold voltage, and common-mode output voltage.



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DRIVER SECTION

electrical characteristics over recommended operating conditions (unless otherwise noted)

| PARAMETER | | TEST CONDITIONS | | MIN | TYP† | MAX | UNIT |
|--------------------|-----------------------------------------------------------------|--------------------------------------------------------|------------------|-----|------|------|-------|
| VIK | Input clamp voltage | $I_{I} = -18 \text{ mA}$ | | | | -1.5 | V |
| | | $R_1 = 54 \Omega$, | SN65LBC180 | 1.1 | 2.5 | 5 | |
| 11/2-1 | Differential output voltage magnitude | See Figure 1 | SN75LBC180 | 1.5 | 2.5 | 5 | 1 , 1 |
| IVODI | (see Note 3) | $R_1 = 60 \Omega$ | SN65LBC180 | 1.1 | 2 | 5 | V |
| | | See Figure 2 | SN75LBC180 | 1.5 | 2 | 5 | |
| Δ V _{OD} | Change in magnitude of differential output voltage (see Note 4) | See Figures 1 and 2 | | | | ±0.2 | V |
| Voc | Common-mode output voltage | | | 1 | 2.5 | 3 | V |
| Δ V _{OC} | Change in magnitude of common-mode output voltage (see Note 4) | $R_L = 54 \Omega$, | See Figure 1 | | | ±0.2 | ٧ |
| IO | Output current with power off | $V_{CC} = 0$, $V_{O} = -7 \text{ V to } 12 \text{ V}$ | | | | ±100 | μΑ |
| loz | High-impedance-state output current | $V_0 = -7 \text{ V to } 12 \text{ V}$ | | | | ±100 | μΑ |
| lн | High-level input current | V _I = 2.4 V | | | | -100 | μΑ |
| I _I L | Low-level input current | V _I = 0.4 V | | | | -100 | μΑ |
| los | Short-circuit output current | -7 V ≤ V _O ≤ 12 V | | | | ±250 | mA |
| laa | Supply current | Danair an dianklad | Outputs enabled | | | 5 | mA |
| Icc | | Receiver disabled | Outputs disabled | | | 3 | IIIA |

- † All typical values are at V_{CC} = 5 V and T_A = 25°C.

 NOTES: 3. The minimum V_{OD} specification of the SN65LBC180 may not fully comply with ANSI RS-485 at operating temperatures below 0°C. System designers should take the possibly lower output signal into account in determining the maximum signal-transmission
 - 4. $\Delta |V_{OD}|$ and $\Delta |V_{OC}|$ are the changes in the steady-state magnitude of V_{OD} and V_{OC} , respectively, that occur when the input is changed from a high level to a low level.

switching characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$

| | PARAMETER | TEST CO | ONDITIONS | MIN | TYP | MAX | UNIT |
|---------------------|-------------------------------------|----------------------|--------------|-----|-----|-----|------|
| td(OD) | Differential output delay time | $R_1 = 54 \Omega$ | See Figure 3 | 7 | 12 | 18 | ns |
| t _t (OD) | Differential output transition time | KL = 54.02, | See Figure 3 | 5 | 10 | 20 | ns |
| ^t PZH | Output enable time to high level | $R_L = 110 \Omega$, | See Figure 4 | | | 35 | ns |
| t _{PZL} | Output enable time to low level | $R_L = 110 \Omega$, | See Figure 5 | | | 35 | ns |
| ^t PHZ | Output disable time from high level | $R_L = 110 \Omega$, | See Figure 4 | | | 50 | ns |
| ^t PLZ | Output disable time from low level | $R_L = 110 \Omega$, | See Figure 5 | | | 35 | ns |



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RECEIVER SECTION

electrical characteristics over recommended operating conditions (unless otherwise noted)

| PARAMETER | | TEST CONDITIONS | | MIN | TYP | MAX | UNIT |
|------------------|-----------------------------------------------------------|----------------------------------------------|--------------------------|------|------|------|------|
| V _{IT+} | Positive-going input threshold voltage | $I_O = -8 \text{ mA}$ | | | | 0.2 | V |
| VIT- | Negative-going input threshold voltage | I _O = 8 mA | | -0.2 | | | V |
| V _{hys} | Hysteresis voltage (V _{IT+} - V _{IT-}) | | | | 45 | | mV |
| ٧ıK | Enable-input clamp voltage | I _I = -18 mA | | | | -1.5 | V |
| Vон | High-level output voltage | $V_{ID} = 200 \text{ mV},$ | $I_{OH} = -8 \text{ mA}$ | 3.5 | 4.5 | | V |
| V_{OL} | Low-level output voltage | $V_{ID} = -200 \text{ mV},$ | $I_{OL} = 8 \text{ mA}$ | | 0.3 | 0.5 | V |
| loz | High-impedance-state output current | $V_O = 0 V \text{ to } V_{CC}$ | | | | ±20 | μΑ |
| lіН | High-level enable-input current | V _{IH} = 2.4 V | | | | -50 | μΑ |
| IլL | Low-level enable-input current | V _{IL} = 0.4 V | | | | -100 | μΑ |
| | <u>.</u> | V _I = 12 V, Other input at 0 V | V _{CC} = 5 V, | | 0.7 | 1 | |
| Ιţ | | V _I = 12 V, Other input at 0 V | VCC = 0 V, | | 0.8 | 1 | mA |
| | Bus input current | $V_I = -7 \text{ V},$ Other input at 0 V | V _{CC} = 5 V, | | -0.5 | -0.8 | MA |
| | | $V_I = -7 \text{ V},$ Other input at 0 V | V _{CC} = 0 V, | | -0.5 | -0.8 | |
| loo | Supply current | Driver disabled | Outputs enabled | | | 5 | mA |
| ICC | CC Supply current Driver disab | | Outputs disabled | | | 3 | ША |

switching characteristics, V_{CC} = 5 V, T_A = 25°C

| | PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|--------------------|--------------------------------------------------------|-----------------------------------------------------------|-----|-----|-----|------|
| ^t PHL | Propagation delay time, high- to low-level output | | 11 | 22 | 33 | ns |
| ^t PLH | Propagation delay time, low- to high-level output | V 45 V 45 V 600 Figure 6 | 11 | 22 | 33 | ns |
| t _{sk(p)} | Pulse skew (t _{PHL} - t _{PLH}) | $V_{ID} = -1.5 \text{ V to } 1.5 \text{ V},$ See Figure 6 | | 3 | 6 | ns |
| t _t | Transition time | | | 5 | 8 | ns |
| ^t PZH | Output enable time to high level | | | | 35 | ns |
| tPZL | Output enable time to low level | See Figure 7 | | | 30 | ns |
| tPHZ | Output disable time from high level | | | | 35 | ns |
| t _{PLZ} | Output disable time from low level | | | | 30 | ns |

PARAMETER MEASUREMENT INFORMATION

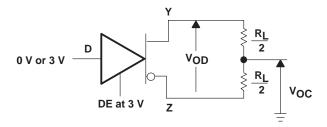


Figure 1. Differential and Common-Mode Output Voltages

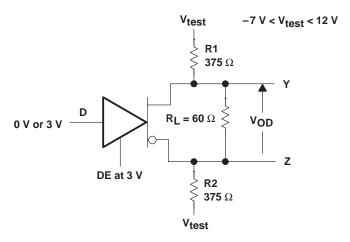
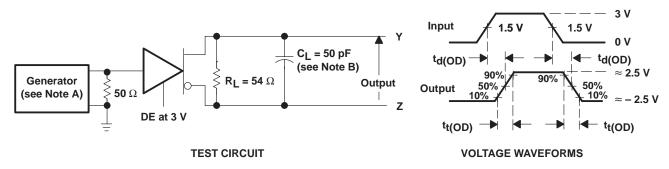


Figure 2. Driver $V_{\mbox{\scriptsize OD}}$ Test Circuit



NOTES: A. The input pulse is supplied by a generator having the following characteristics: PRR > 1 MHz, 50% duty cycle, $t_f \le 6$ ns, $t_f \le$

B. CL includes probe and jig capacitance.

Figure 3. Driver Test Circuit and Differential Output Delay and Transition Time Voltage Waveforms



PARAMETER MEASUREMENT INFORMATION

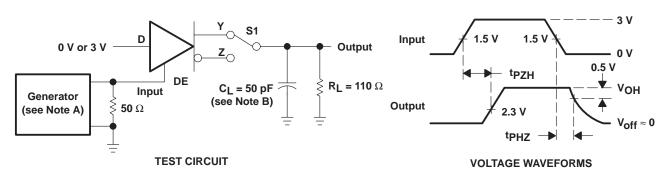


Figure 4. Driver Test Circuit and Enable and Disable Time Waveforms

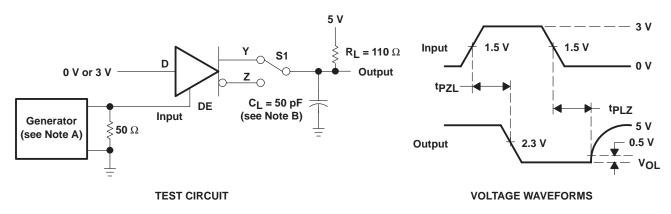
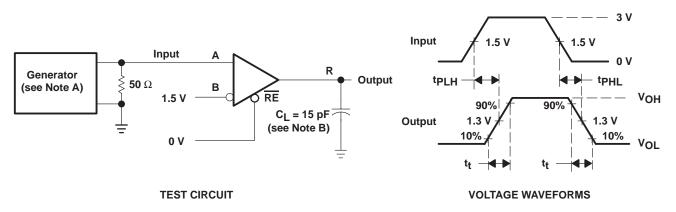


Figure 5. Driver Test Circuit and Enable and Disable Time Voltage Waveforms



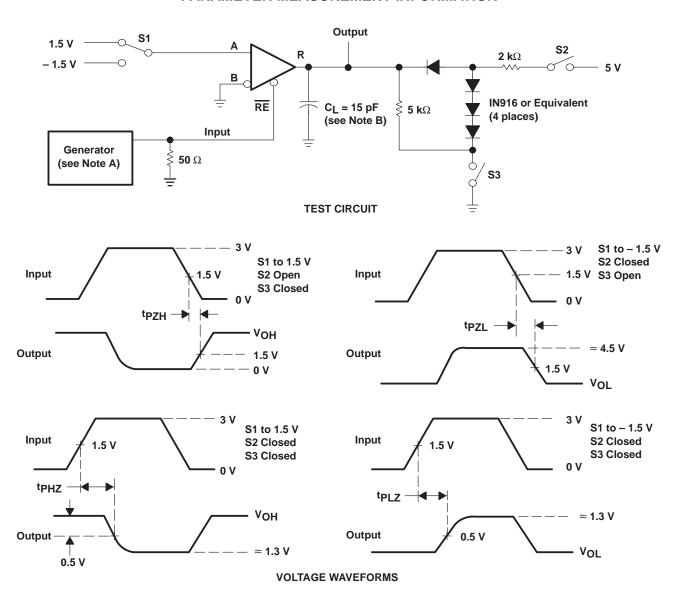
NOTES: A. The input pulse is supplied by a generator having the following characteristics: PRR \leq 1 MHz, 50% duty cycle, $t_f \leq$ 6 ns, $t_f \leq$ 8 ns, $t_f \leq$ 8 ns, $t_f \leq$ 9 ns, t_f

B. C_L includes probe and jig capacitance.

Figure 6. Receiver Test Circuit and Propagation Delay Time Voltage Waveforms



PARAMETER MEASUREMENT INFORMATION



NOTES: A. The input pulse is supplied by a generator having the following characteristics: PRR \leq 1 MHz, 50% duty cycle, $t_f \leq$ 6 ns, $t_f \leq$ 8 ns, $t_f \leq$ 8 ns, $t_f \leq$ 9 ns, t_f

B. C_L includes probe and jig capacitance.

Figure 7. Receiver Output Enable and Disable Times



DRIVER

LOW-LEVEL OUTPUT VOLTAGE

vs

TYPICAL CHARACTERISTICS

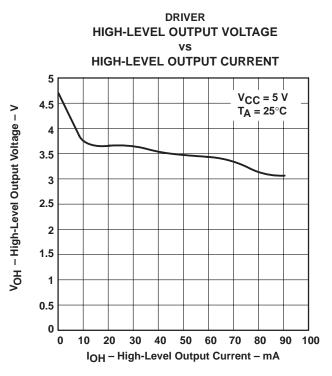
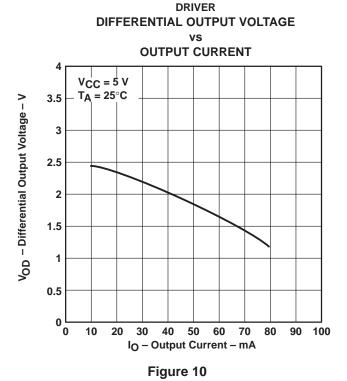


Figure 8



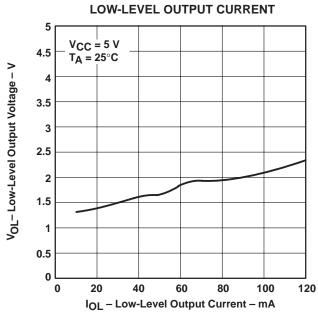


Figure 9

DRIVER DIFFERENTIAL OUTPUT VOLTAGE VS

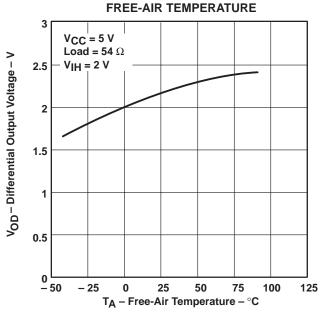
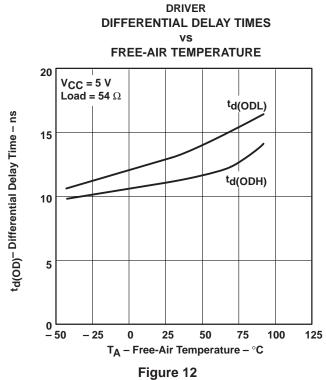


Figure 11



TYPICAL CHARACTERISTICS

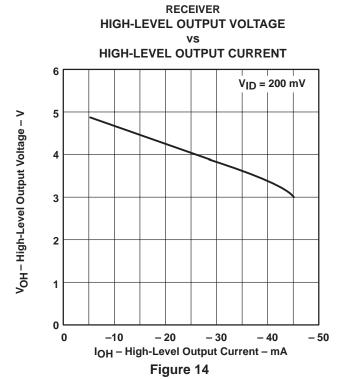


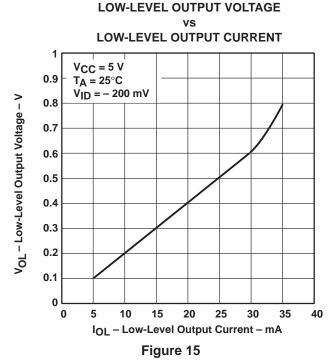
SUPPLY VOLTAGE 80 $R_L = 54 \Omega$ 60 loL 40 Output Current - mA 20 0 -20 -40 Іон -60 -80 6 V_{CC} - Supply Voltage - V Figure 13

DRIVER

OUTPUT CURRENT

vs





RECEIVER



TYPICAL CHARACTERISTICS

RECEIVER OUTPUT VOLTAGE vs **DIFFERENTIAL INPUT VOLTAGE** 5 V_{IC} = 12 V Vo - Output Voltage - V V_{IC} = 0 V 3 2 V_{IC} = -7 V - 80 - 60 - 40 - 20 60 80 V_{ID} - Differential Input Voltage - mV

Figure 16

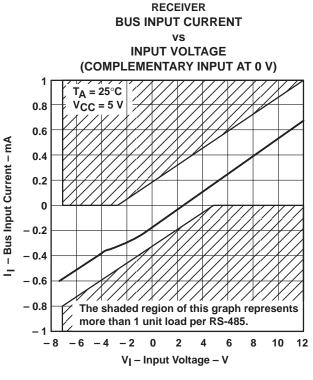


Figure 18

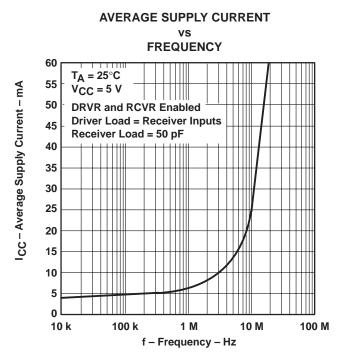


Figure 17

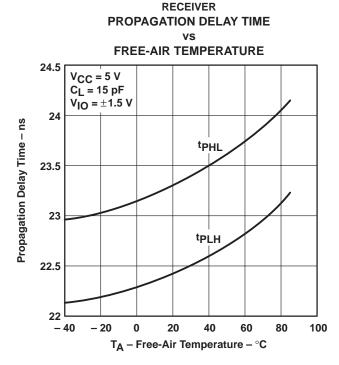
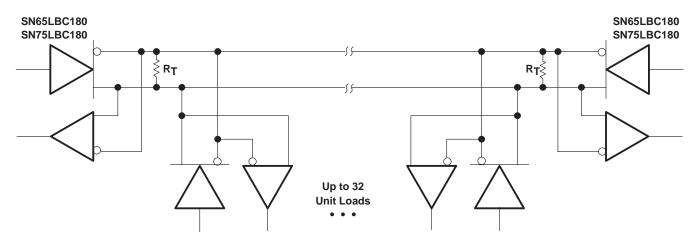


Figure 19



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APPLICATION INFORMATION



NOTE A: The line should be terminated at both ends in its characteristic impedance ($R_T = Z_O$). Stub lengths off the main line should be kept as short as possible. One SN75LBC180 typically represents less than one unit load.

Figure 20. Typical Application Circuit



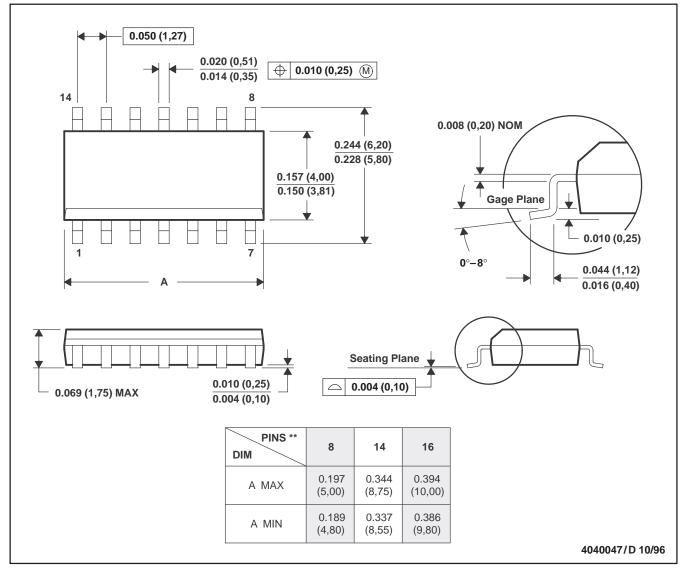
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MECHANICAL DATA

D (R-PDSO-G**)

14 PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion, not to exceed 0.006 (0,15).

D. Falls within JEDEC MS-012



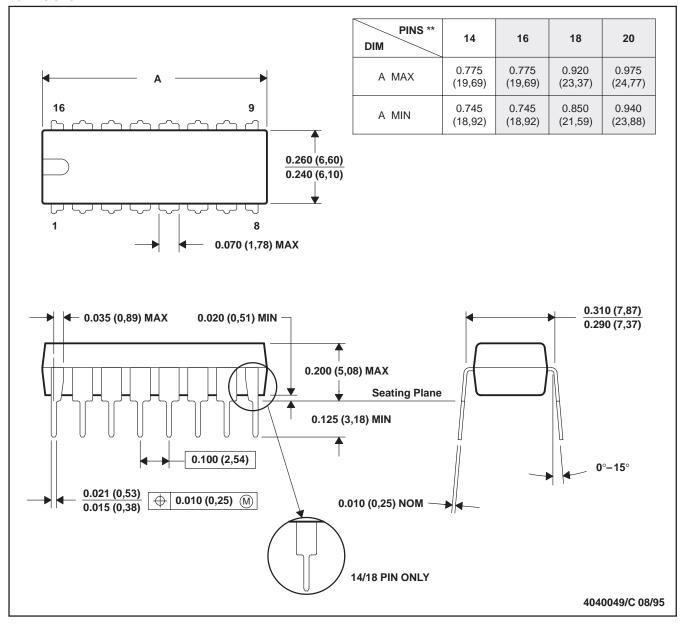
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MECHANICAL DATA

N (R-PDIP-T**)

16 PINS SHOWN

PLASTIC DUAL-IN-LINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. Falls within JEDEC MS-001 (20-pin package is shorter than MS-001).



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